

Notice of References Cited	Application/Control No. 10/551,436		Applicant(s)/Patent Under Reexamination AVNI ET AL.	
	Examiner Nhon T. Diep		Art Unit 2621	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,124,888	09-2000	Terada et al.	348/302
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